Docket No.

251241US2/hc

IN THE UNITED ATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF:

Katsufumi EHATA

SERIAL NO:

: 10/812,887

GAU:

FILED:

March 31, 2004

EXAMINER:

FOR:

METHOD AND APPARATUS FOR MEASURING COMPLEX DIELECTRIC CONSTANT OF DIELECTRIC

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

SIR:

Applicant(s) wish to disclose the following information.

REFERENCES

- The applicant(s) wish to make of record the references listed on the attached form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.
- A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

- Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present application. A copy of the patent(s), together with a copy of the claims and drawings of the pending application(s) is attached along with PTO 1449.
- ☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

- ☐ Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- □ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

Marvin J. Spivak

Registration No. 24,913 Joseph A. Scafetta, Jr. Registration No. 26, 803

Customer Number

22850

Tel. (703) 413-3000 Fax. (703) 413-2220 (OSMMN 05/03)



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF:

Katsufumi EHATA

SERIAL NO: 10/812,887

GROUP:

FILED:

March 31, 2004

EXAMINER:

FOR:

METHOD AND APPARATUS FOR MEASURING COMPLEX DIELECTRIC

CONSTANT OF DIELECTRIC

STATEMENT OF RELEVANCY

All of the references on Form PTO-1449 are discussed in the specification.

Form PTO 1449		SENE CATE DEN	T OF COMMERCE	ATTY DOCKET NO.			SERIAL NO.		
(Modified)		PATENT AND TR	ADEMARK OFFICE	251241US2			10/812,887		
				APPLICANT					
LIST OF	REFE	RENCES CITED BY A	PPLICANT	Katsufumi EH	ATA				
4				FILING DATE			GROUP		
				March 31, 2004					
_				U.S. PATENT DO			·		
EXAMINER		DOCUMENT DATE		NAME CLASS		SUB FILING DATE			
INITIAL		NUMBER				02.00	CLASS	IF APPROPRIATE	
	AA								
	AB								
	AC								
	AD								
	AE								
	AF								
	AG								
	АН								
	AI								
	AJ				- \.				
	AK					-		***	
	AL								
	AM								
-	AN								
	<u> </u>		FO	REIGN PATENT D	OCUMENTS				
 		DOCUMENT		1			1		
	DOCUMENT DATE			COUNTRY			TRANSLATION		
	AO	6-138076	05/20/1994	JAPAN			YES	S NO	
	AP	3 100010	00/20/1004	JAI AN	····				
	AQ								
	<u> </u>								
	AR		 						
	AS		_						
	AT			ļ					
	AU					<u></u>			
	AV			<u></u>					
		OTHER R	REFERENCES (Including Author,	Title, Date, Perti	nent Pages, e	tc.)		
		Y. IIJIMA, pages 20-2	23, "ELECTRON	NC MONTHLY", 19	98				
	AW								
	-	JIS R 1627, Japanes	e Standards As	sociation, pages 1-	18, "TESTING ME	THOD FOR D	IELECTRI	C PROPERTIES O	FFINE
	AX	CERAMICS AT MICE	ROWAVE FREC	UENCY", July 199	6				
		JIS R 1641, Japanese Standards Association, pages 1-29, "TESTING METHOD FOR DIELEC						C PROPERTIES OF	FFINE
	AY	CERAMIC PLATES A	AT MICROWAV	E FREQUENCY", .	lanuary 2002				
	·								
	AZ					Addi	tional Refe	rences sheet(s) att	ached
Examiner			<u></u>		4. ₹	Data C	Date Considered		
				19TT					
*Examiner: In conformance	itial if r	eference is considered of considered, Include of	I, whether or not	t citation is in confo	mance with MPE	P 609; Draw lir	ne through	citation if not in	

WIN 20 TON EST